

Enabling low-mass dark matter searches by detecting xenon infrared scintillation

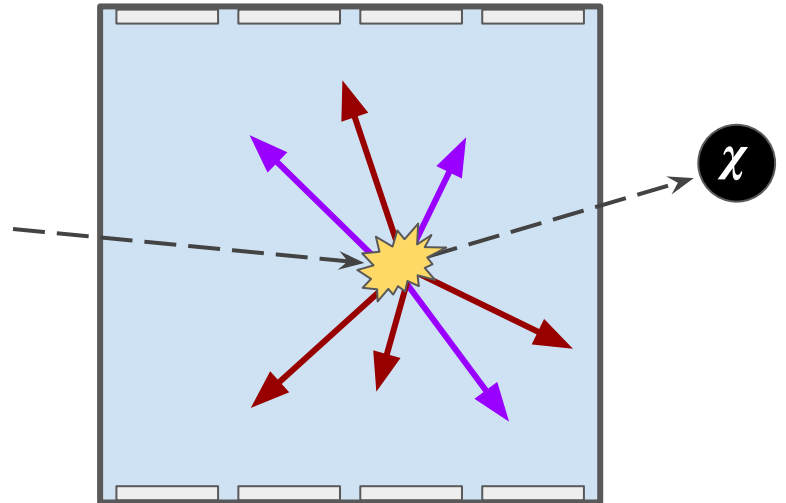
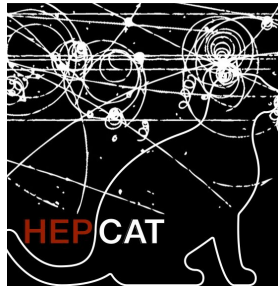
Ryan Gibbons (UC Berkeley, LBNL)

HEPCAT Meeting – November 1, 2024

Berkeley
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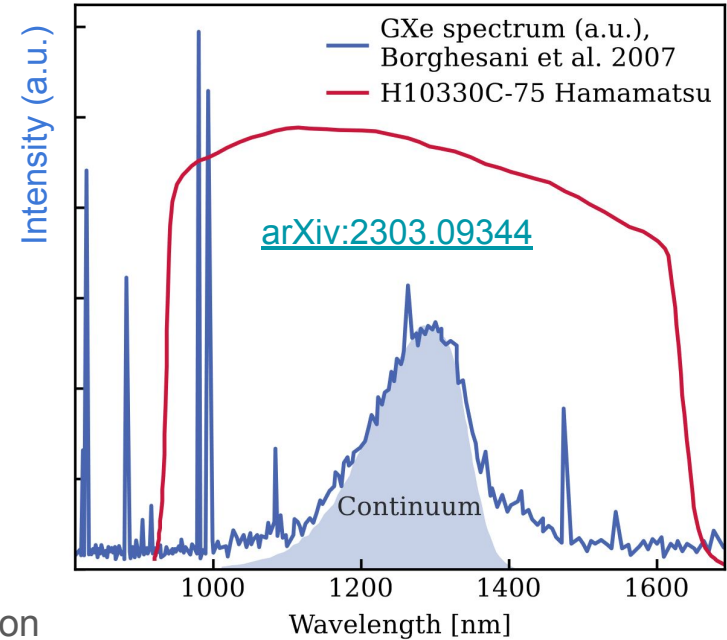
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Why measure infrared (IR)?

- Well-known: VUV (175 nm) Xe scintillation
- Less-known: IR (1-1.4 μm) also emitted

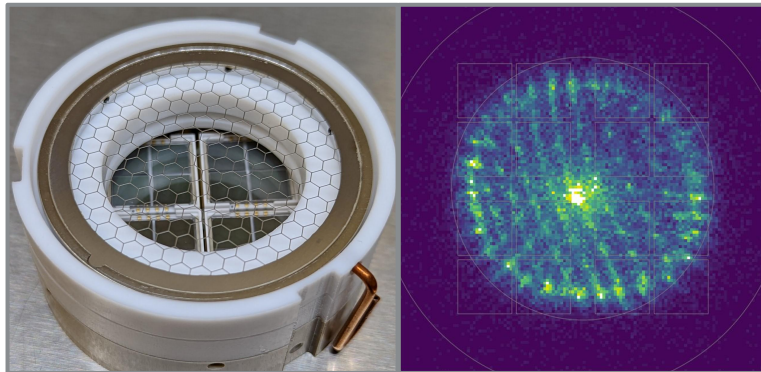
- Application: dark matter detectors (LZ-IR)
- Increase sensitivity to sub-GeV dark matter
 - Boost light yield \rightarrow lower threshold + better E-resolution
 - New background discrimination quantity?



Goal: measure IR in dual-phase xenon time projection chamber (TPC)

Investigating with TPC test stand at LBNL

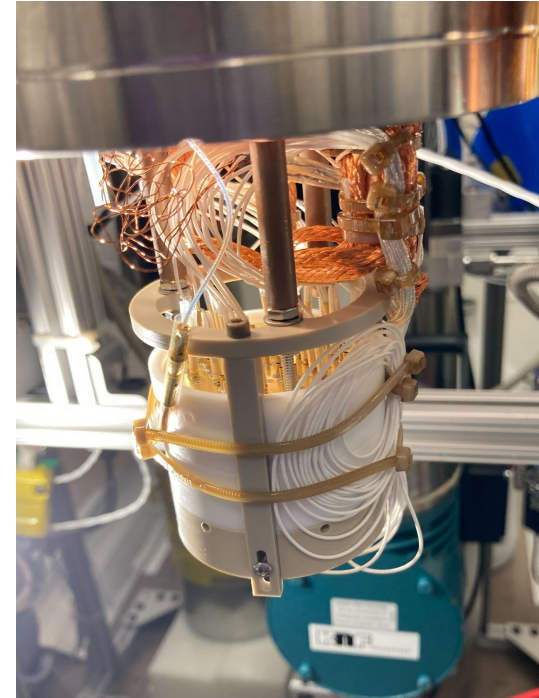
- ~700 g dual-phase Xe TPC, PTFE walls
- **Swap SiPMs for IR detectors**
- Multi-purpose detector:
 - Solid Xe TPC (crystalLiZe): [arXiv:2312.15082](https://arxiv.org/abs/2312.15082), [arXiv:2201.05740](https://arxiv.org/abs/2201.05740)
 - H/He-doping Xe (HydroX): [arXiv:2308.02430](https://arxiv.org/abs/2308.02430)
 - SiPM R&D: [arXiv:2309.07913](https://arxiv.org/abs/2309.07913)



SiPMs and electrode

Example (x,y) reconstruction

Assembled TPC

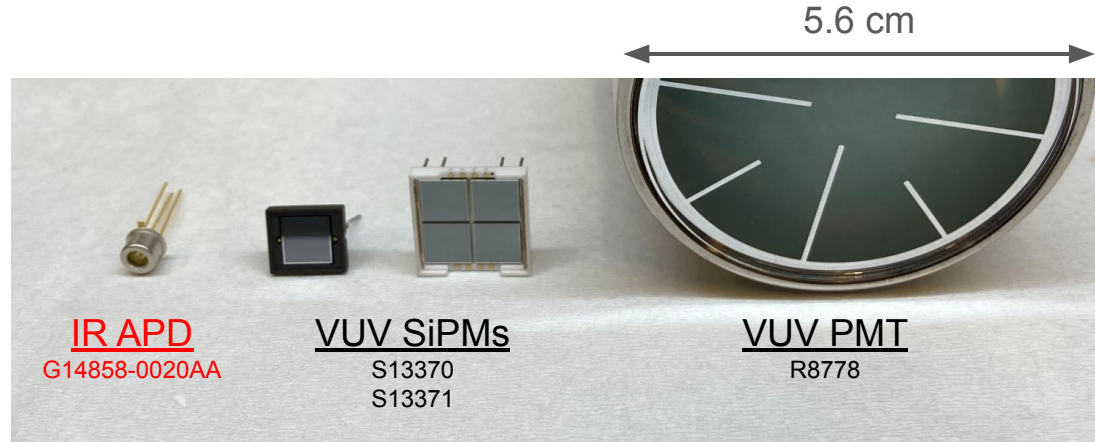
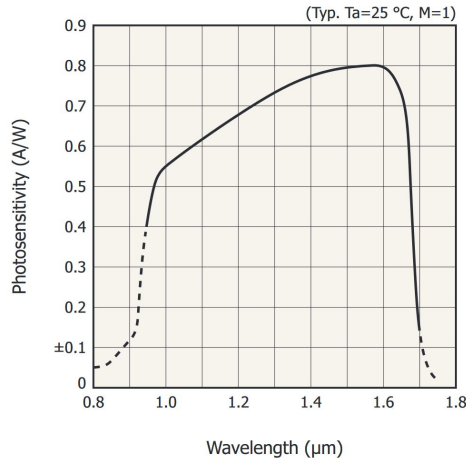


Measuring low-light IR is tricky

- InGaAs detectors are best option
 - IR PMTs awkward to use in TPC (and prohibitively expensive)
 - Christmas wish list: [InGaAs MPPC](#) (unavailable commercially)
- Using InGaAs APDs

Apologies for too many acronyms:

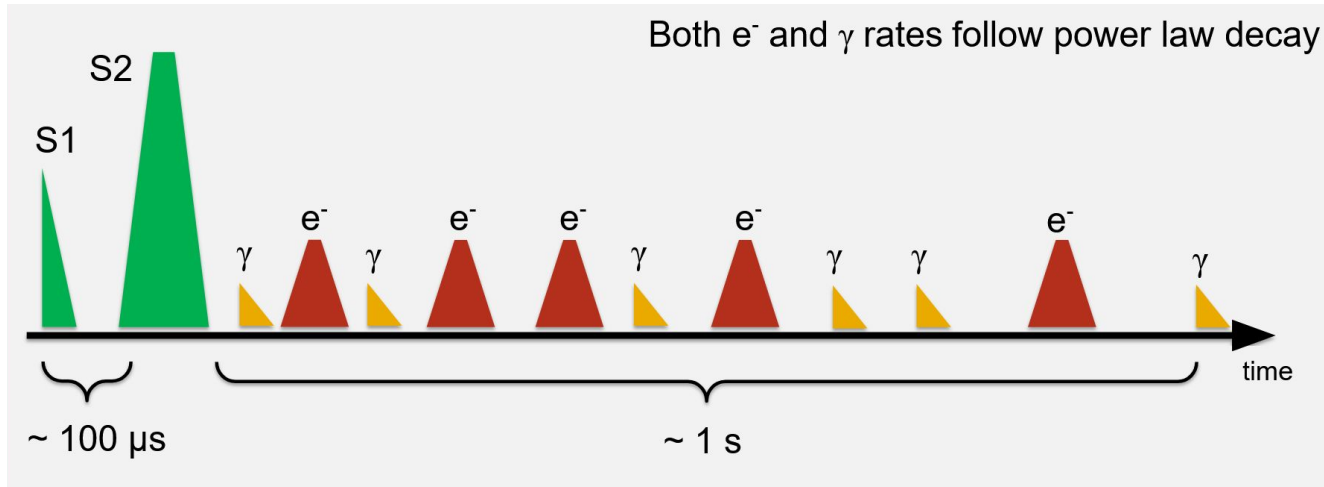
- PMT: photomultiplier tube
- MPPC: multi-pixel photon counter
- SiPM: silicon photomultiplier
- APD: avalanche photodiode
- SPAD: single-photon avalanche diode



Hamamatsu family at LBNL Xenon Lab

Dominant background: delayed photon emission

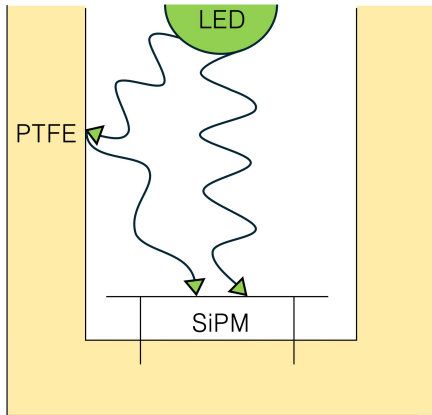
- Delayed photon (and electron) emission plagues dual-phase xenon TPCs
 - Likely has prompt IR component
- Hypothesis of mechanism: **PTFE fluorescence*** induced by VUV light



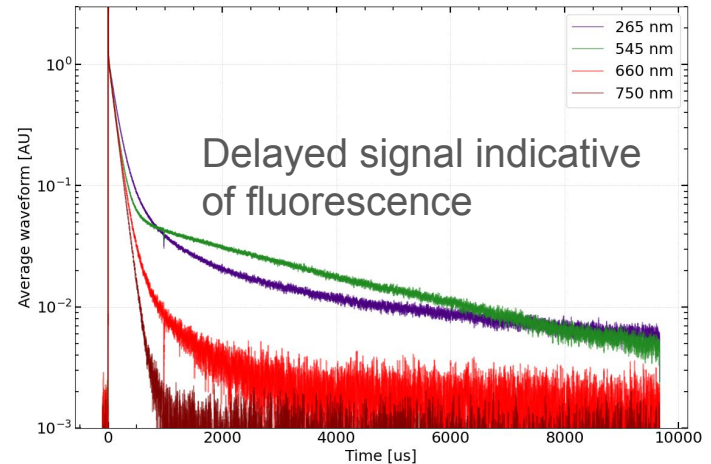
* technically phosphorescence...

New test-stand to characterize PTFE fluorescence

- Use UV LED to stimulate PTFE fluorescence
- Result: **fluorescence from LED glass bulb dominates signal**

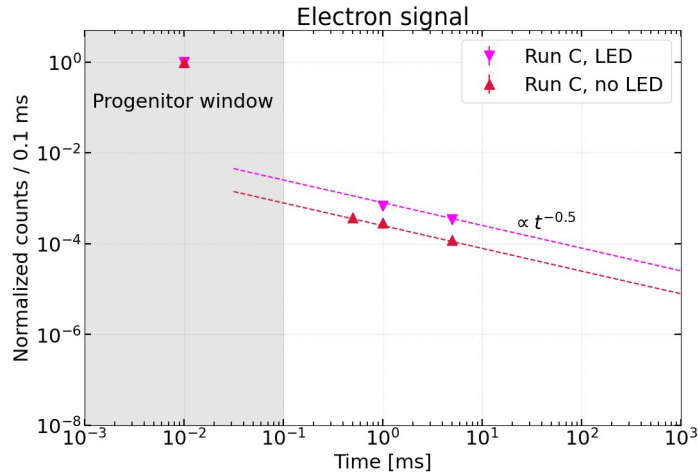


Work with undergrad Leah Douglas



Important aside: delayed photons cause delayed electrons

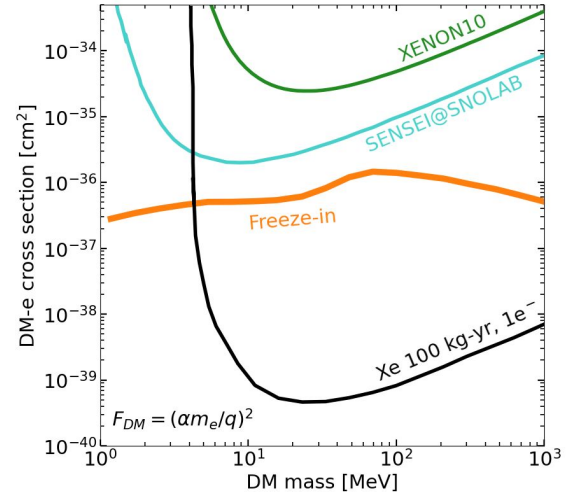
- UV LED flash induces both delayed photons and delayed electrons
- First conclusive data of dominant mechanism for delayed electrons
- Why it matters: **remove delayed electrons** → **sub-GeV dark matter search**



Delayed electrons increased with LED flash



Background free Xe TPC potential



More info: [\[here\]](#), [\[and here\]](#)

What's causing delayed photons?

- **Dominant component is not from PTFE**
 - Swapped PTFE for aluminum (no HV!)
 - Delayed photons still present!
 - Also not from stainless steel grids
- **What do we know?**
 - Seen in both PMTs and SiPMs
 - > 280 nm (no DPE in PMTs)
 - No dependence on impurities in Xe
 - **Nightmare scenario: metastable Xe atomic lines?** (see [arXiv:2410.22863](https://arxiv.org/abs/2410.22863))
- Under current investigation



No *shocking* discoveries with aluminum :)

Summary and future work

- Detecting IR scintillation can enhance Xe TPC dark matter search
- Likely background from delayed photon emission
- New results for understanding delayed photon and electron emission
 - Publication forthcoming
- **IR measurements planned in early 2025**

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